REMARKS

Claims 1-7 remain in this application. Claim 1 has been amended. No claims have been added or cancelled. The Applicants respectfully request reconsideration of this application in view of the above amendments and the following remarks.

Interview Summary

Applicants would like to thank the Examiner for granting the telephonic interview that was conducted in the present application on November 15, 2005 at 11:00 MST. The participants in the interview included the Examiner and the undersigned. The purpose of the interview was to discuss the 35 U.S.C. 102(e) rejection of claim 1 on U.S. Patent No. 6,535,659 to Levy. The substance of the interview included verbally summarizing the arguments that were previously presented in the response that was filed on September 16, 2005 with regards to Levy. Applicants and Examiner tentatively agreed that Levy did not teach or reasonably suggest performing electrical and optical testing of the performance of a planar lightwave circuit, such as, for example, to discover defects, perform debug, and/or ensure device operation, or the like. No exhibits were shown or demonstrated.

35 U.S.C. §102(e) Rejection - Levy

The Examiner has rejected claim 1 under 35 U.S.C. §102(e) as being anticipated by U.S. Patent No. 6,535,659 issued to Levy et al. ("Levy").

As an initial matter, <u>Levy</u> may not represent effective prior art to the present application because of Applicant's early date of invention. However, while making this statement, and reserving the right to swear behind <u>Levy</u> in the future, the Applicant chooses at this time to present arguments pointing out certain differences between claim

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Claim 1 recites "A method of electrically and optically testing a planar lightwave circuit comprising: placing the planar lightwave circuit on a test fixture the test fixture including a printed circuit board; electrically coupling the printed circuit board to the planar lightwave circuit; electrically coupling the printed circuit board to a tester; optically coupling the planar lightwave circuit to the tester; and performing electrical and optical testing of performance of the planar lightwave circuit".

Levy does not teach or reasonably suggest either: (a) optically coupling the planar lightwave circuit to the tester; or (b) optically testing performance of the planar lightwave circuit. Rather, as Applicants have previously argued, Levy discusses electrically testing waveguide array units (see for example the Field of the Invention).

In the previous Office Action mailed on 06/16/05, at page four under the section "Response to Arguments", the Examiner has stated "Examiner disagrees because at lines 39-41 of column 1, Lavy discloses testing of an electrical integrity of the planar lightwave circuit. Lavy also uses tester (control circuit 26) to control the beam of planar lightwave circuit using electrical connection 28 and 30. Therefore, the planar lightwave circuit is optically and electrically connected to the tester as claimed for testing (i.e. to control a beam). Also, the planar lightwave circuit is on test fixture 22 during testing, therefore argument regarding interconnect unit 10 is not true".

Applicants respectfully disagree with the Examiner's understanding. There is absolutely no teaching or suggestion that control circuit 26 is a "tester" or that the integrated optical interconnect unit 10 shown in Figure 1 is used to test the waveguide array structure. As understood by Applicants the optical interconnect unit 10 shown in Figure 1 is not used for testing of the waveguide array. Further, Levy

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specifically teaches that "[a]n integrated waveguide array structure allows electrical testing of each unit for shorts between waveguide elements of the array, and shorts between waveguides and the substrate prior to assembly into a larger optico-electronic unit" (see e.g., the Abstract). Furthermore, there is absolutely no teaching or suggestion

that control circuit 26 perform optical testing of performance of the planar lightwave

circuit.

<u>Levy</u> discusses how the electrical testing may be performed at column 5, lines 19-

32. "Referring again to FIG. 3, an individual waveguide array 44 is electrically tested by

applying leads of a suitable test instrument (not shown), such as an ohmmeter, to each

of the cross bars 56, 60." "After completion of electrical testing, the right terminal

segment 54 and the left terminal segment 58 are separated from the central segment 46

using scribe lines 70, 72, and discarded. The central segment 46 is then ready for

assembly in an optico-electronic device according to a particular application without

fear of malfunction due to electrical shorts in the waveguide array." Applicants submit

that this is clearly an electrical test not an optical test.

Accordingly, Levy does not teach or reasonably suggest either: (a) optically

coupling the planar lightwave circuit to the tester; or (b) optically testing the planar

lightwave circuit.

Anticipation under 35 U.S.C. Section 102 requires every element of the claimed

invention be identically shown in a single prior art reference. The Federal Circuit has

indicated that the standard for measuring lack of novelty by anticipation is strict identity.

"For a prior art reference to anticipate in terms of 35 U.S.C. Section 102, every element

of the claimed invention must be identically shown in a single reference." In Re Bond,

910 F.2d 831, 15 USPQ.2d 1566 (Fed. Cir. 1990).

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For at least these reasons, claim 1 is believed to be allowable over <u>Levy</u>. Claims 2-7 depend from claim 1 and are believed to be allowable therefor, as well as for the

recitations independently set forth therein.

35 U.S.C. §103(a) Rejection - <u>Levy</u> in view of <u>Forsyth</u>

The Examiner has rejected claims 2-7 under 35 U.S.C. §103(a) as being

unpatentable over Levy as applied to claim 1 above, and further in view of U.S. Patent

No. 4,910,548 issued to Forsyth et al. ("Forsyth").

Firstly, Applicants do not think that it is appropriate to combine Levy and

Forsyth. Applicants may elect at a later date to argue formally that Levy and Forsyth

should not be combined.

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Secondly, the combination of Levy and Forsyth proposed by the Examiner does

not teach or suggest all of the limitations of claim 1. As discussed above, Levy does not

discuss optical testing, let alone optical testing of performance. Forsyth does not remedy

what is missing from Levy in this regard.

To establish a prima facie case of obviousness, three basic criteria must be met.

First, there must be some suggestion or motivation, either in the references themselves or

in the knowledge generally available to one of ordinary skill in the art, to modify the

references or to combine reference teachings. Second, there must be a reasonable

expectation of success. Finally, the prior art reference (or references when combined)

must teach or suggest all the claim limitations. The teaching or suggestion to make the

claimed combination and the reasonable expectation of success must both be found in the

prior art, and not based on Applicant's disclosure. In re Vaeck, 947 F.2d 488, 20

USPO2d 1438 (Fed. Cir. 1991).

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Accordingly, **claim 1** and its dependent **claims 2-7** are believed to be allowable over <u>Levy</u> and <u>Forsyth</u>.

Conclusion

In view of the foregoing, it is believed that all claims now pending patentably

define the subject invention over the prior art of record and are in condition for

allowance. Applicants respectfully request that the rejections be withdrawn and the

claims be allowed at the earliest possible date.

Request For Telephone Interview

The Examiner is invited to call Brent E. Vecchia at (303) 740-1980 if there

remains any issue with allowance of the case.

Request For An Extension Of Time

The Applicants respectfully petition for an extension of time to respond to the

outstanding Office Action pursuant to 37 C.F.R. § 1.136(a) should one be necessary.

Please charge our Deposit Account No. 02-2666 to cover the necessary fee under 37

C.F.R. § 1.17 for such an extension.

Charge Our Deposit Account

Please charge any shortage to our Deposit Account No. 02-2666.

Respectfully submitted,

BLAKELY, SOKOLOFF, TAYLOR & ZAFMAN LLP

Date: Nov. 16, 2005

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